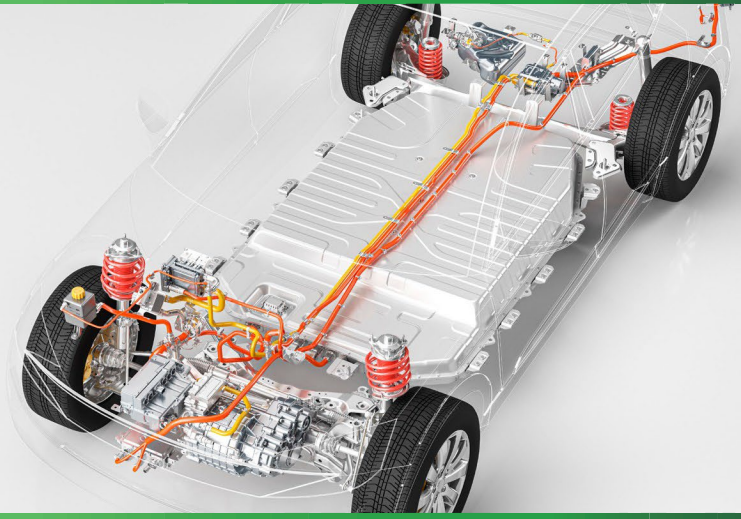




TCLAD INC.

Insulated Metal Substrate (IMS) with Embedded Thermal Pyrolytic Graphite (TPG), IMSwTPG, for Wide-Bandgap Semiconductor Power Modules

Steve Taylor - TCLAD
Garry Wexler - TCLAD



Step on the pedal of a modern electric vehicle (EV) and you will feel quick, smooth acceleration. This smooth acceleration is due to improvements in converting DC battery energy into three-phase AC power that controls torque and speed. Although most headlines focus on advancements in EV battery design, it is improvements in power switching in the traction inverter that has led to better performance and power management in the vehicle's propulsion system.

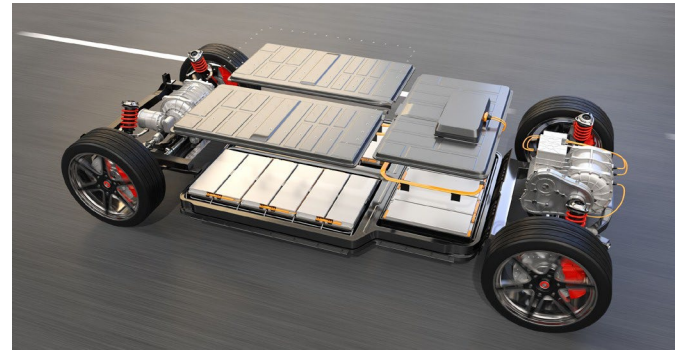


Figure-1 Automotive Traction Inverter

The demand for advanced high-performance power systems is far-reaching. Many industries are searching for innovative materials and technologies that will meet the needs of next generation power electronics. Trends in the marketplace are toward more compact power devices that can operate under extreme conditions. Higher temperatures, higher switching frequencies and higher blocking voltages are in demand, while efficiency and reliability issues are obstacles that need to be overcome.

WIDE-BANDGAP SEMICONDUCTOR TECHNOLOGIES

An emerging technology of considerable interest is wide-bandgap (WBG) metal-oxide semiconductor field-effect transistors (MOSFETs). Based on silicon carbide (SiC) or gallium nitride (GaN), WBG MOSFETs possess higher thermal conductivities and blocking voltages than conventional silicon (Si) based MOSFETS, making them better suited for handling higher power densities and higher temperatures.

While WBG semiconductors are capable of superior performance under extreme conditions where excessive heat is a major concern, this ability is useless without advancements in the substrates upon which these devices are mounted. Power-dense applications of next generation power electronics will require advanced substrates with advanced thermal, electrical, and mechanical performance.



STANDARD SUBSTRATES FOR TRADITIONAL POWER MODULES

Traditional power modules are constructed on direct-bonded copper (DBC) substrates consisting of a ceramic isolator, typically low-cost Al_2O_3 (aluminum oxide), sandwiched between two layers of copper (Cu).

Figure-2 shows a standard DBC half-bridge power module with single sided cooling. Tracks, die attachment, wire bond landing and termination attachments are on top. The bottom layer is used as a contact area for mounting a heat sink or other cooling structure.

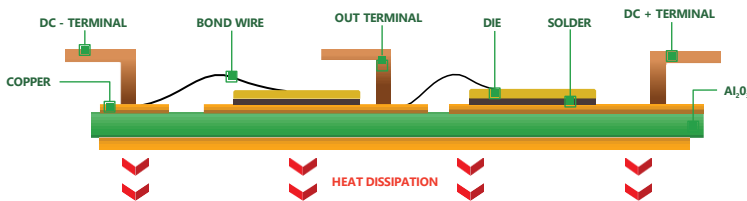


Figure-2 DBC-Based Half-Bridge Power Module

Standard DBC substrates have worked well for traditional silicon-based power modules. However, when exposed to extreme temperature fluctuations, they experience considerable mechanical stress due to differing coefficients of thermal expansion (CTEs), leading to early system failures.

Low breakdown voltage of Al_2O_3 is another limitation. In most power electronic applications, the cooling system is grounded, therefore the ceramic in the DBC substrate must possess a high enough breakdown voltage to survive the voltage potential between the top layer nodes and the ground.

ALTERNATIVE DBC CERAMICS

Some improvements in thermal performance have been demonstrated by utilizing different ceramic materials such as AlN (aluminum nitride) and Si_3N_4 (silicon nitride), but they have not yet sufficiently overcome fundamental challenges.

- AlN DBC shows improved heat transfer and higher breakdown voltage compared to Al_2O_3 DBC, but AlN is brittle, requiring thicker layers to compensate. Flatness fluctuation due to CTE mismatch of copper and AlN during temperature cycling can affect long term reliability, as well.
- Si_3N_4 DBC substrates are mechanically stronger than AlN DBC and offer better heat transfer than Al_2O_3 DBC, but bonding Si_3N_4 to copper is a much more difficult and costly operation.

INSULATED METAL SUBSTRATE (IMS)

IMS is a novel improvement to DBC for power electronic applications. TCLAD, a leading provider of thermal management materials, has developed a portfolio of dielectric polymer-ceramic coatings used to insulate the conductive layers in power module substrates. The dielectric polymer is applied between a metal (typically aluminum or copper) base and the copper circuit layer, providing many benefits including excellent electrical isolation, superior heat transfer and durability. TCLAD IMS materials have excellent dielectric strength and can be processed in very thin layers to reduce the overall thermal resistance of the substrate. The basic structure of an IMS substrate is shown in Figure-3.



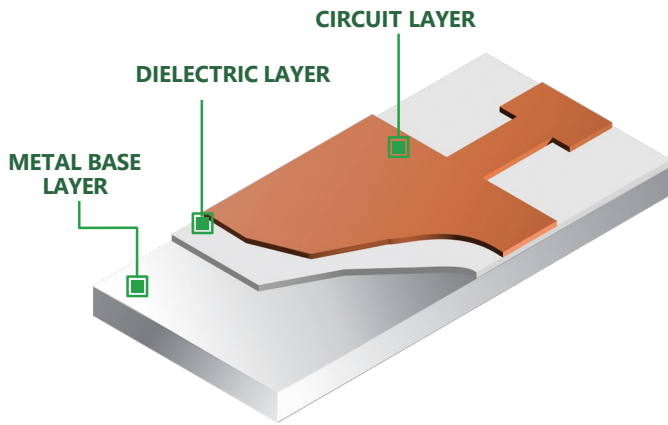


Figure-3 Structure of IMS Substrate

GRAPHITE THERMAL MANAGEMENT SOLUTIONS

Graphite has long played an important role in thermal management of power electronics due to its high thermal conductivity and low density compared to copper and aluminum. For example,

- Thermal interface materials infused with graphite assist with heat dissipation, improving the heat flux of aluminum heat spreaders by up to 50%.
- Natural-graphite-sheet (NGS) is a relatively new development that is being used successfully for heat sinks improving air-cooling in power converters. NGS heat sinks are lighter weight and substantially reduce diode junction temperatures compared to conventional aluminum heat sinks.

ADVANCED THERMALLY ANNEALED PYROLYTIC GRAPHITE (TPG)

TPG has emerged as a promising high performance thermal management solution. TPG is a synthetic form of graphite formulated via a high-temperature chemical vapor deposition process and heat treatment above 3,000°C to create a highly aligned anisotropic

multi-layer graphite structure with very high in-plane (x-axis) thermal conductivity ($>1500 \text{ W/m}^2\text{K}$). Due to its relative brittle nature, it is embedded in metal (typically copper) for protection and to make it available for direct die attach. Properly oriented, TPG also achieves excellent thermal conductivity ($>700 \text{ W/m}^2\text{K}$) in the through-plane (z-axis) and in the cross-plane (y-axis).

IMS WITH TPG COMPOSITE SUBSTRATES OUTPERFORM AIN DBC SUBSTRATES

TCLAD has taken a novel approach toward meeting the needs of next generation high power electronics. They have developed an integrated solution that combines IMS and TPG technologies to create higher performance IMSwTPG substrates. Figure-4 shows an IMSwTPG half-bridge power module with single sided cooling.

IMSwTPG substrates outperform conventional DBC substrates by simultaneously achieving higher thermal conductivity from TPG and excellent mechanical, and thermal properties of IMS.

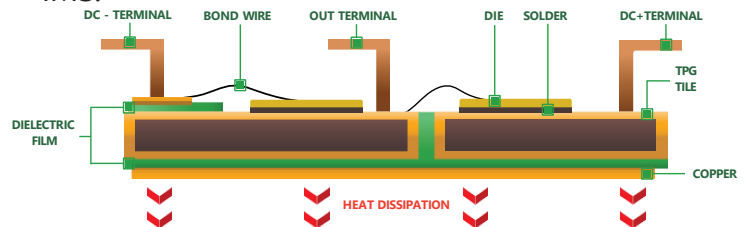


Figure-4 IMSwTPG-Based Half-Bridge Power Module

THE PROOF IS IN THE ANALYSIS

Of course, combining two good things together to create something great may feel obvious. But it is always good to test the concept, gathering all the necessary information to become more



certain. Research and experimentation always help the innovation process, and IMSwTPG has been rigorously researched and tested.

The following provides highlights of recent independent analyses performed by experts in the industry to validate TCLAD’s novel IMSwTPG substrate for higher performance WBG power devices.

FINITE ELEMENT ANALYSIS (FEA) - SETUP

FEA simulations were run for WBG power modules based on AlN DBC and IMSwTPG substrates with six SiC MOSFETs (M1-M6) mounted in parallel. Electrical and thermal operating conditions were representative of one-sided liquid cooling commonly used in automotive applications. Steady-state and transient simulations were conducted.

Figure-5 shows the module layout for the FEA simulations. Figure-6 shows the expanded structure of the IMSwTPG substrate.

- DBC substrate consists of a 640 μm thick AlN ceramic insulator sandwiched between 300 μm thick copper planes.
- IMSwTPG substrate is constructed with 1.10 mm thick TPG tiles hermetically encapsulated inside 0.25-mm thick Cu skins and isolated from the bottom copper layer using a 152 μm thick TCLAD HT dielectric polymer-ceramic film layer.

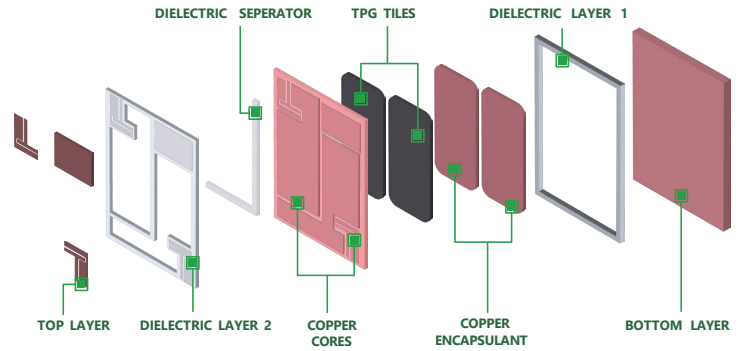


Figure-6 Expanded IMSwTPG Structure

FEA RESULTS

- Steady-state FEA simulations predict that heat spreading across the AlN DBC would be limited and concentrated around the SiC MOSFETs.
- In contrast, the steady-state FEA simulations predict better heat spreading within the IMSwTPG substrate and reduced junction temperatures of the SiC MOSFETs due to a reduction in thermal impedance.
- Transient FEA simulations predict that this type of substrate would strongly influence the transient junction-to-coolant thermal impedance (Z_{th}). Between 10 milliseconds and 1 second, the simulations showed the IMSwTPG substrate outperforming the DBC substrate by more than 40%.
- To quantify the impact on the module’s current carrying capability, current density was calculated at various conditions. The results predict that the IMSwTPG substrate can provide a 10% increase in device current density compared to AlN DBC.

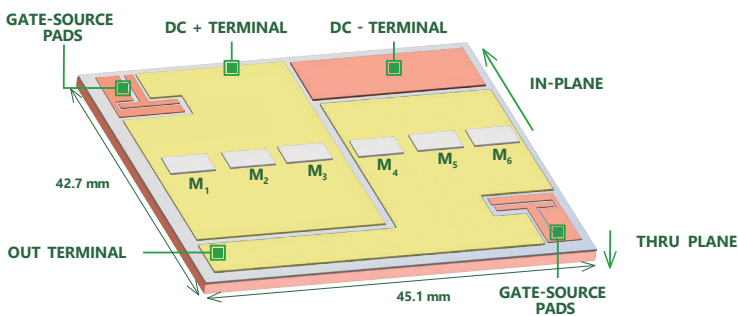


Figure-5 Test Module Layout



EXPERIMENTAL TEST SETUP

Thermal performance tests were setup to match the anatomy and conditions of the FEA simulations and included both steady-state and transient analyses. Additionally, the electrical performance of the IMSwTPG power module was evaluated at static and dynamic conditions.

- SiC MOSFET die surface temperatures were measured using an infrared (IR) thermal camera.
- Die junction temperatures and temperatures on the base of the substrate were directly measured by thermocouples.
- Three different liquid coolant temperatures were used (25, 45 and 65°C) with regulated flow rate.
- Power losses across each die were measured by probing the current through the device and the voltage across the terminals.

EXPERIMENTAL TEST RESULTS VALIDATE FEA SIMULATIONS

Figures-7 and 8 show thermal images of test modules under steady-state conditions and at 25°C coolant temperature. These images clearly indicate better heat spreading within the IMSwTPG-based module, in agreement with the FEA results.

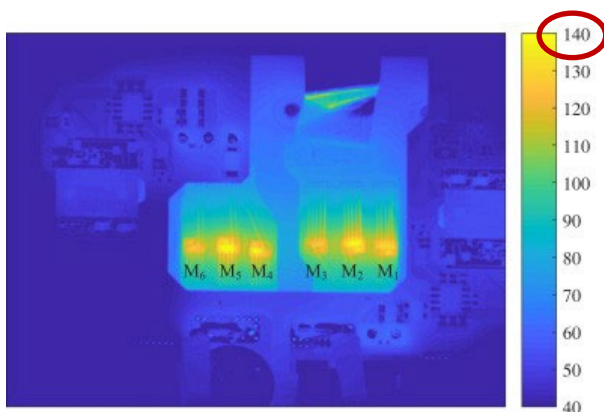


Figure-7 DBC substrate

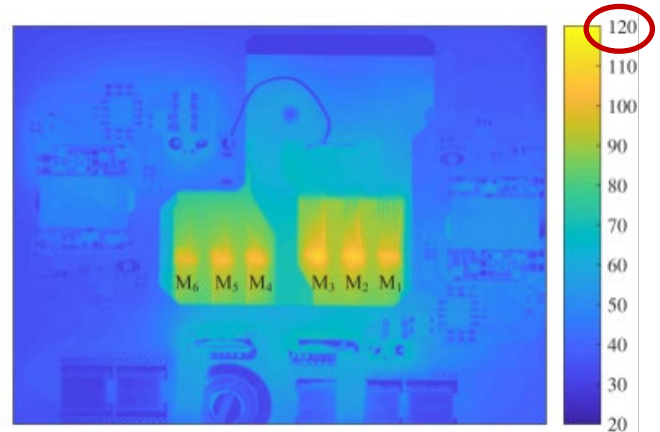


Figure-8 IMSwTPG substrate

Figure-9 graphically compares transient thermal impedance (Z_{th}) of the SiC MOSFET dies on the DBC and IMSwTPG substrates. The observed reduction in thermal impedance between 10 milliseconds and 1 second is well matched with the FEA results.

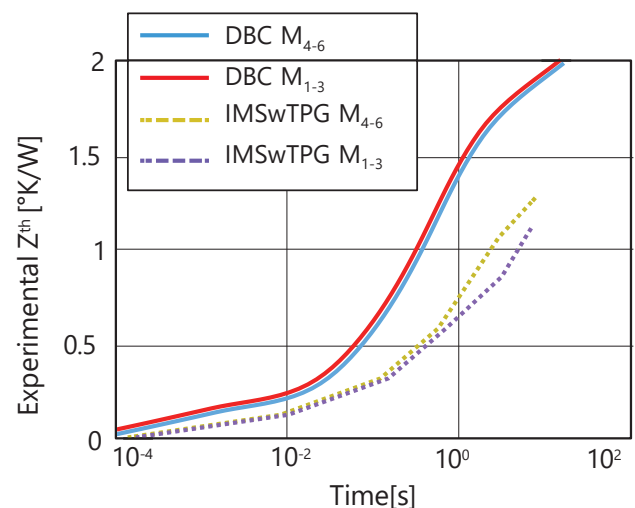


Figure-9 Comparison of Transient Thermal Impedance on DBC and IMSwTPG

Additionally, static, and dynamic electrical characterizations of the IMSwTPG-based module under high current and voltage conditions indicated that the graphite core had virtually no impact on the ON-state resistance and switching performance of the SiC MOSFET dies.

For the complete IEEE paper please email:
sales.us@tclad.com



CONCLUSION

Moving from an AlN DBC to an IMSwTPG solution will enable superior performance of next generation wide-bandgap power modules.

TCLAD's innovative approach of combining the high thermal conductivity from TPG with the superior mechanical and electrical properties from IMS achieves better heat distribution throughout the power module due to:

- Up to 40% reduction in transient thermal impedance,
- Up to 17% reduction in junction-to-case thermal resistance of SiC MOSFETs,
- Up to 10% increase in device current density,
- And has virtually no impact on the ON-state resistance and switching performance.

TCLAD's IMS solutions provide enhanced thermal performance compared to DBC by enabling embedded TPG. In addition, TCLAD IMS solutions eliminate issues with unbalanced copper thickness and enable greater design flexibility by accommodating:

- Complex multi-layer circuit designs,
- Mounting holes and other mechanical features in the base metal,
- A variety of PCB shapes and sizes.

TCLAD's comprehensive IMS portfolio offers solutions to fit a variety of applications, from power conversion and solid-state relays and switches to motor drives and LEDs.

The authors would like to acknowledge Dr. Wei Fan from Momentive Technologies, Dr. Emre Gulpinar and Dr. Burak Ozpinedi from Oakridge National Laboratory, Steve Taylor and Garry Wexler from TLCAD Inc. for their contributions to this project.

To learn more about TCLAD visit tclad.com

AMERICAS

TCLAD INC
1600 Orrin Road, Presco WI
54021, United States
+1.715.262.5898
Sales.us@tclad.com

ASIA-PACIFIC

TCLAD TECHNOLOGY CORP.
No. 24-1 Industry E. Rd. IV,
Hsinchu Science Park, Hsinchu
300 TAIWAN
+886.3.564.3931
Sales.asia@tclad.com

EUROPE

TCLAD EUROPE GmbH
Sprendlingerstraße 28, 55546
Pfaffen-Schwabenheim
55546 Germany
+49.6352.6788210
Sales.eu@tclad.com

Across the Board, Around the Globe, TCLAD is the most recognized IMS thermal management material for performance and reliability.

All marks used above are trademarks and or registered trademarks of TCLAD Inc and its affiliates in the U.S., Germany and elsewhere.
©2023 TCLAD Inc All rights reserved.

